

Reliability Monitoring Results

Quarters: Q1/2021 to Q4/2021 Based on structural similarity

Supplier User Part Number

Nexperia B.V. 74LVC1T45GN

Part Description: Single dual-supply voltage level translating transceiver (3-state)

Function Family: LVC Process family: Sub micron Package family: XSON

JESD47		Test Conditions	Duration	# Lots	# Quantity	# Rejects
# 1	TEST Pre- and Post-Stress Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below
# 2	PC Preconditioning	JESD22-A113 MSL 1	N/A	1007	27163	0
# 5a	HTOL EFR High Temperature Operating Life Extrinsic	JESD22-A108 Tj = 150°C $V_{CCMAX} \le V \le 1.2*V_{CCMAX}$	48 hours or 168 hours	122	29837	0
# 5b	HTOL IFR High Temperature Operating Life Intrinsic	JESD22-A108 Tj = 150°C $V_{CCMAX} \le V \le 1.2*V_{CCMAX}$	≥500 hours	70	5655	0
# 7	TC Temperature Cycling	JESD22-A104 -65 °C to 150°C	≥500 cycles	548	15036	0
# 9	uHAST / HAST unbiased or biased High Accelerated Stress Test	JESD22-A101 Tamb = 130 °C, RH = 85%, $V = V_{CCMAX}$	96 hours	520	12127	0

Calculation of PPM, FIT and MTTF

Test considered for PPM calculation: High Temperature Operating LifeTest Extrinsic (HTOL EFR, Test # 5a above) Test considered for FIT and MTTF calculations: High Temperature Operating LifeTest Intrinsic(HTOL IFR, Test # 5b above)

Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Product	Package			Extrinsic	Intrinsic	
Family	Family	Quantity	Rejects	Failure Rate (PPM)	Failure Rate (FIT)	MTTF (hrs)
LVC	XSON	5655	0	31	0.6	1.68 E+09